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October 1986
Revised February 2000

FAIRCHILD
SEMICONDUCTOR™

DM74ALS5245
Octal 3-STATE Transceiver

General Description

This octal bus transceiver is designed for asynchronous two-way communication between data buses. The inputs include hysteresis which provides improved noise rejection. Data is transmitted either from the A bus to the B bus or from the B bus to the A bus depending on the logic level of the direction control (DIR) input. The device can be disabled via the enable input ($\overline{G}$) which causes the outputs to enter the high impedance mode so the buses are effectively isolated.

Features

■ Input Hysteresis
■ Low output noise generation
■ High input noise immunity
■ Advanced oxide-isolated, ion implanted Schottky TTL process
■ Switching specification guaranteed over the full temperature and V_{CC} range
■ PNP inputs to reduce input loading

Ordering Code:

Order Number	Package Number	Package Description
DM74ALS5245WM	M20B	20-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300 Wide
DM74ALS5245SJ	M20D	20-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide
DM74ALS5245N	N20A	20-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

Connection Diagram
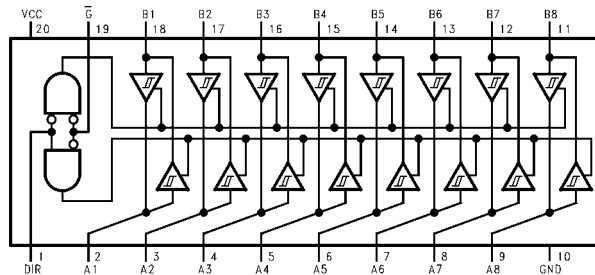
Function Table

Control Inputs		Operation
$\overline{G}$	DIR	
L	L	B Data to A Bus
L	H	A Data to B Bus
H	X	High Impedance

L = LOW Logic Level   H = HIGH Logic Level   X = Don't Care (Either LOW or HIGH Logic Level)

Absolute Maximum Ratings(Note 1)

Supply Voltage   7V

Input Voltage

    Control Inputs   7V

    I/O Ports   5.5V

Operating Free-Air Temperature Range   0°C to +70°C

Storage Temperature Range   −65°C to +150°C

Typical θ_{JA}

    N Package   56.0°C/W

    M Package   74.0°C/W

Note 1: The "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. The device should not be operated at these limits. The parametric values defined in the Electrical Characteristic tables are not guaranteed at the absolute maximum ratings. The "Recommended Operating Conditions" table will define the conditions for actual device operation.

Recommended Operating Conditions

Symbol	Parameter	Min	Max	Units
V_{CC}	Supply Voltage	4.5	5.5	V
V_{IH}	HIGH Level Input Voltage	2		V
V_{IL}	LOW Level Input Voltage		0.8	V
I_{OH}	HIGH Level Output Current		−15	mA
I_{OL}	LOW Level Output Current		24	mA
T_A	Free Air Operating Temperature Range	0	70	°C

Electrical Characteristics

over recommended free air temperature range. All typical values are measured at V_{CC} = 5V, T_A = 25°C.

Symbol	Parameter	Test Conditions		Min	Typ	Max	Units
V_{IK}	Input Clamp Voltage	V_{CC} = Min, I_I = −18 mA				−1.5	V
H_{YS}	Hysteresis ($V_{T+} - V_{T-}$)	V_{CC} = Min		0.2	0.32		V
V_{OH}	HIGH Level	V_{CC} = 4.5V to 5.5V	I_{OH} = −0.4 mA	$V_{CC} - 2$			
	Output Voltage	V_{CC} = Min	I_{OH} = −3 mA	2.4	3.2		V
			I_{OH} = Max	2			
V_{OL}	LOW Level	V_{CC} = Min	I_{OL} = 12 mA		0.25	0.4	V
	Output Voltage		I_{OL} = 24 mA		0.35	0.5	
I_I	Input Current at	V_{CC} = Max	I/O Ports, V_I = 5.5V			100	μA
	Maximum Input Voltage		Control Inputs, V_I = 7V			100	
I_{IH}	HIGH Level Input Current	V_{CC} = Max, V_I = 2.7V				20	μA
I_{IL}	LOW Level Input Current	V_{CC} = Max, V_I = 0.4V				−100	μA
I_O	Output Drive Current	V_{CC} = Max, V_O = 2.25V		−30		−112	mA
I_{CC}	Supply Current	V_{CC} = Max	Outputs HIGH		30	45	
			Outputs LOW		36	55	mA
			Outputs Disabled		38	58	
V_{OLP}	Quiet Output Maximum Dynamic V_{OL}	V_{CC} = 5.0V, T_A = 25°C (Figures 1, 2; (Note 2)(Note 3))			0.5		V
V_{OLV}	Quiet Output Minimum Dynamic V_{OL}	V_{CC} = 5.0V, T_A = 25°C (Figures 1, 2; (Note 2)(Note 3))			−0.2		V
V_{IHD}	Minimum High Level Dynamic Input Voltage	V_{CC} = 5.0V, T_A = 25°C (Note 2)(Note 4)			1.6		V
V_{ILD}	Maximum Low Level Dynamic Input Voltage	V_{CC} = 5.0V, T_A = 25°C (Note 2)(Note 4)			1.0		V

Note 2: Plastic DIP package.

Note 3: n = number of device outputs; n–1 outputs switching, each driven 0V to 3V one output @ GND.

Note 4: n = number of device outputs; n outputs switching, n–1 inputs switching 0V to 3V. Input under test switching 3V to threshold (V_{ILD}); 0V to threshold (V_{IHD}); f = 1 MHz.

Switching Characteristics

over recommended operating free air temperature range

Symbol	Parameter	Conditions	From (Input) To (Output)	Min	Max	Units
t_{PLH}	Propagation Delay Time LOW-to-HIGH Level Output	V_{CC} = 4.5V to 5.5V, $R_1 = R_2 = 500\Omega$, C_L = 50 pF	A or B to B or A	3	10	ns
t_{PHL}	Propagation Delay Time HIGH-to-LOW Level Output		A or B to B or A	3	10	ns
t_{PZH}	Output Enable Time to HIGH Level Output		$\overline{G}$ to A or B	5	20	ns
t_{PZL}	Output Enable Time to LOW Level Output		$\overline{G}$ to A or B	5	20	ns
t_{PHZ}	Output Disable Time from HIGH Level Output		$\overline{G}$ to A or B	2	10	ns
t_{PLZ}	Output Disable Time from LOW Level Output		$\overline{G}$ to A or B	4	15	ns

ALS Noise Characteristics

The setup of a noise characteristics measurement is critical to the accuracy and repeatability of the tests. The following is a brief description of the setup used to measure the noise characteristics of ALS.

Equipment:

    Word Generator

    Printed Circuit Board Test Fixture

    Dual Trace Oscilloscope

Procedure:

1. Verify Test Fixture Loading: Standard Load 50 pF, 500Ω.

2. Deskew the word generator so that no two channels have greater than 150 ps skew between them. This requires that the oscilloscope be deskewed first. Swap out the channels that have more than 150 ps of skew until all channels being used are within 150 ps. It is important to deskew the word generator channels before testing. This will ensure that the outputs switch simultaneously.

3. Terminate all inputs and outputs to ensure proper loading of the outputs and that the input levels are at the correct voltage.

4. Set V_{CC} to 5.0V.

5. Set the word generator to toggle all but one output at a frequency of 1 MHz. Greater frequencies will increase DUT heating and affect the results of the measurement.

6. Set the word generator input levels at 0V LOW and 3V HIGH. Verify levels with a digital volt meter.
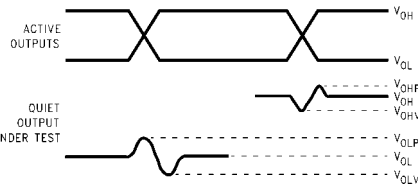

FIGURE 1. Quiet Output Noise Voltage Waveforms

Note 5: V_{OHV} and V_{OHP} are measured with respect to V_{OH} reference. V_{OLV} and V_{OLP} are measured with respect to ground reference.

Note 6: Input pulses have the following characteristics: f = 1 MHz, t_r = 3 ns, t_f = 3 ns, skew < 150 ps.

V_{OLP}/V_{OLV} and V_{OHP}/V_{OHV}:

• Determine the quiet output pin that demonstrates the greatest noise levels. The worst case pin will usually be the furthest from the ground pin. Monitor the output voltages using a 50Ω coaxial cable plugged into a standard SMB type connector on the test fixture. Do not use an active FET probe.

• Measure V_{OLP} and V_{OLV} on the quiet output during the HL transition. Measure V_{OHP} and V_{OHV} on the quiet output during the LH transition.

• Verify that the GND reference recorded on the oscilloscope has not drifted to ensure the accuracy and repeatability of the measurements.

V_{ILD} and V_{IHD}:

• Monitor one of the switching outputs using a 50Ω coaxial cable plugged into a standard SMB type connector on the test fixture. Do not use an active FET probe.

• First increase the input LOW voltage level, V_{IL}, until the output begins to oscillate. Oscillation is defined as noise on the output LOW level that exceeds V_{IL} limits, or on output HIGH levels that exceed V_{IH} limits. The input LOW voltage level at which oscillation occurs is defined as V_{ILD}.

• Next decrease the input HIGH voltage level on the word generator, V_{IH} until the output begins to oscillate. Oscillation is defined as noise on the output LOW level that exceeds V_{IL} limits, or on output HIGH levels that exceed V_{IH} limits. The input HIGH voltage level at which oscillation occurs is defined as V_{IHD}.

• Verify that the GND reference recorded on the oscilloscope has not drifted to ensure the accuracy and repeatability of the measurements.
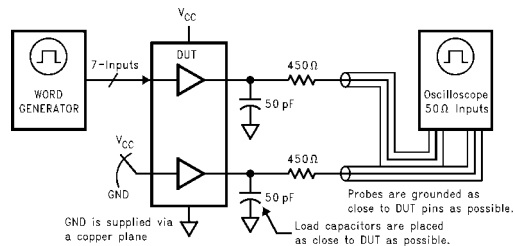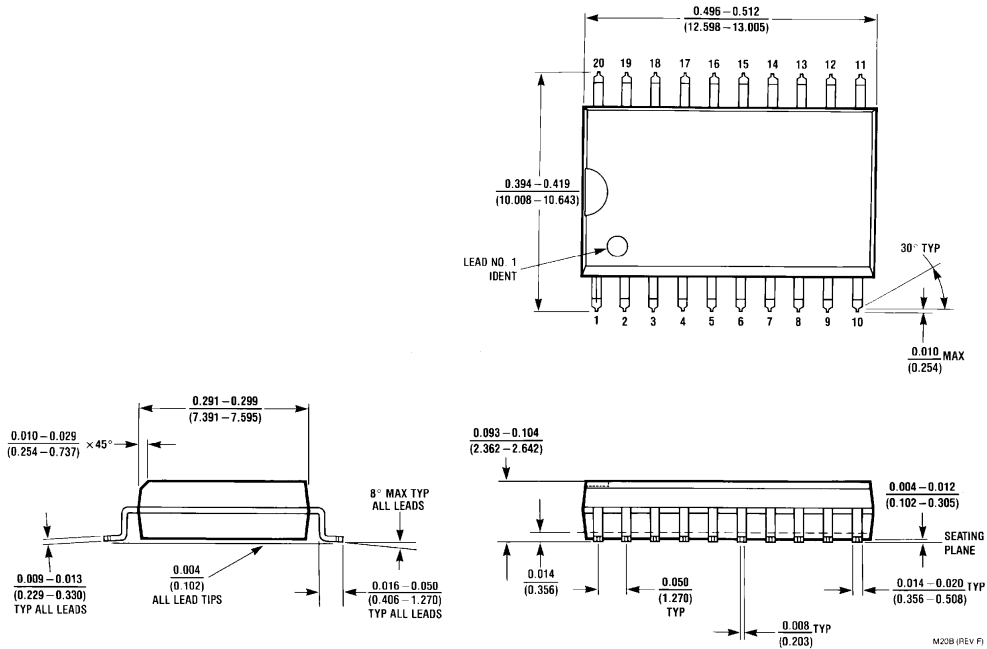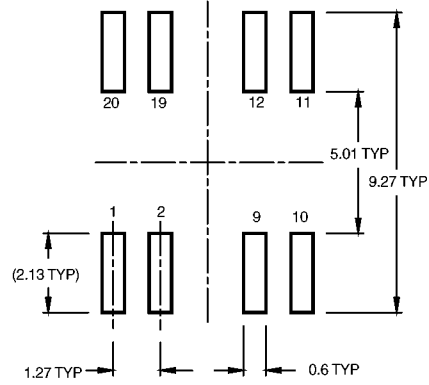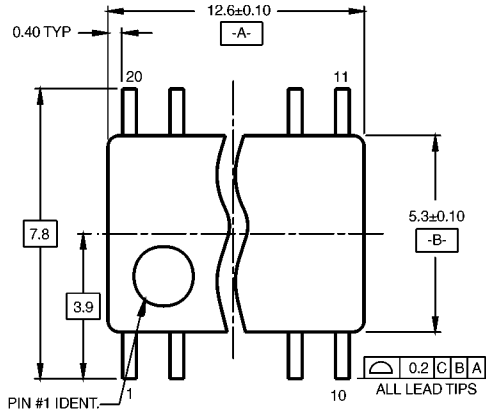

FIGURE 2. Simultaneous Switching Test Circuit

Physical Dimensions inches (millimeters) unless otherwise noted

0.496 − 0.512
(12.598 − 13.005)

20 19 18 17 16 15 14 13 12 11

0.394 − 0.419
(10.008 − 10.643)

LEAD NO. 1
IDENT

1 2 3 4 5 6 7 8 9 10

30° TYP

0.010 MAX
(0.254)

0.291 − 0.299
(7.391 − 7.595)

0.010 − 0.029
(0.254 − 0.737) × 45°

8° MAX TYP
ALL LEADS

0.009 − 0.013
(0.229 − 0.330)
TYP ALL LEADS

0.004
(0.102)
ALL LEAD TIPS

0.016 − 0.050
(0.406 − 1.270)
TYP ALL LEADS

0.093 − 0.104
(2.362 − 2.642)

0.004 − 0.012
(0.102 − 0.305)

SEATING
PLANE

0.014
(0.356)

0.050
(1.270)
TYP

0.008 TYP
(0.203)

0.014 − 0.020 TYP
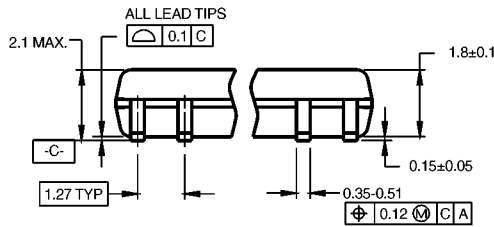(0.356 − 0.508)

M20B (REV F)

20-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300 Wide
Package Number M20B

Physical Dimensions inches (millimeters) unless otherwise noted (Continued)

12.6±0.10
-A-

0.40 TYP

20   11

7.8

3.9

5.3±0.10
-B-

| ⌂ | 0.2 | C | B | A |
ALL LEAD TIPS

PIN #1 IDENT. — 1   10

LAND PATTERN RECOMMENDATION

20 19   12 11

5.01 TYP

9.27 TYP

1   2   9   10

(2.13 TYP)

1.27 TYP   0.6 TYP

ALL LEAD TIPS

| ⌂ | 0.1 | C |

2.1 MAX.

-C-

1.27 TYP

1.8±0.1

0.15±0.05

0.35-0.51

| ⊕ | 0.12 Ⓜ | C | A |

DIMENSIONS ARE IN MILLIMETERS

SEE DETAIL A

0.15-0.25

7° TYP

GAGE PLANE

0°-8° TYP

0.25

0.60±0.15

1.25

SEATING PLANE
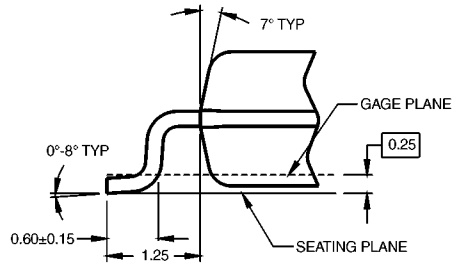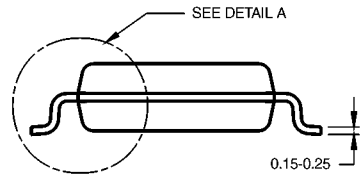
DETAIL A

NOTES:
A. CONFORMS TO EIAJ EDR-7320 REGISTRATION, ESTABLISHED IN DECEMBER, 1998.
B. DIMENSIONS ARE IN MILLIMETERS.
C. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.

M20DRevB1

20-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide
Package Number M20D

Physical Dimensions inches (millimeters) unless otherwise noted (Continued)
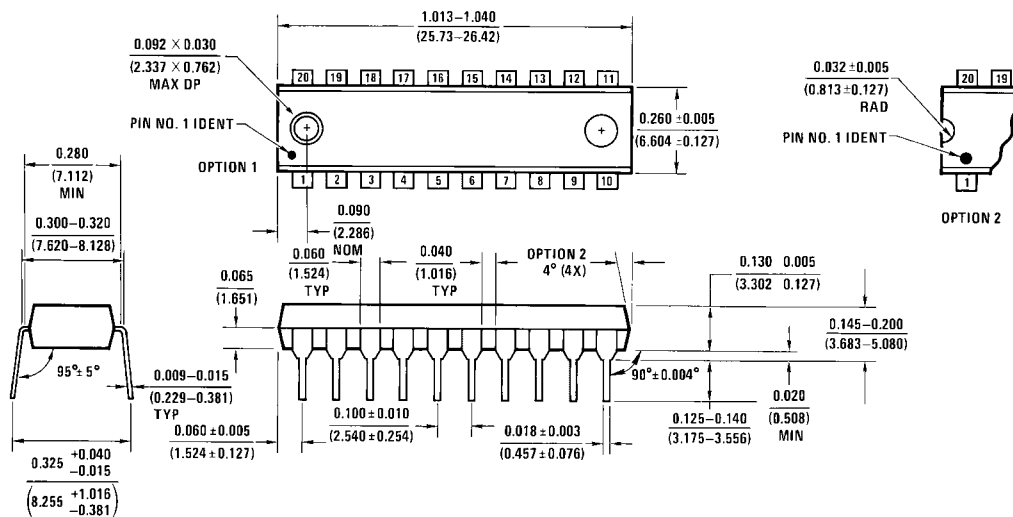
20-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide
Package Number N20A

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2. A critical component in any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

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